Notice of References Cited Application/Control No. 09/653,156 Examiner Thanh T. Nguyen Applicant(s)/Patent Under Reexamination AGARWAL ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,222,722	04-2001	Fukuzumi et al.	361/305
	В	US-6,780,704	08-2004	Raaijmakers et al.	438/239
	С	US-6,551,399	04-2003	Sneh et al.	117/102
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	E	US-			:
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	G	US-			
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FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.